

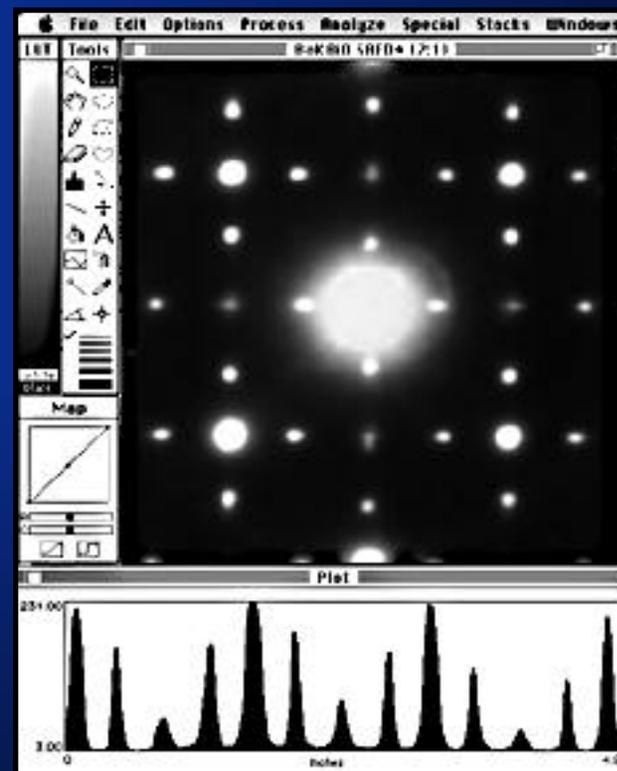
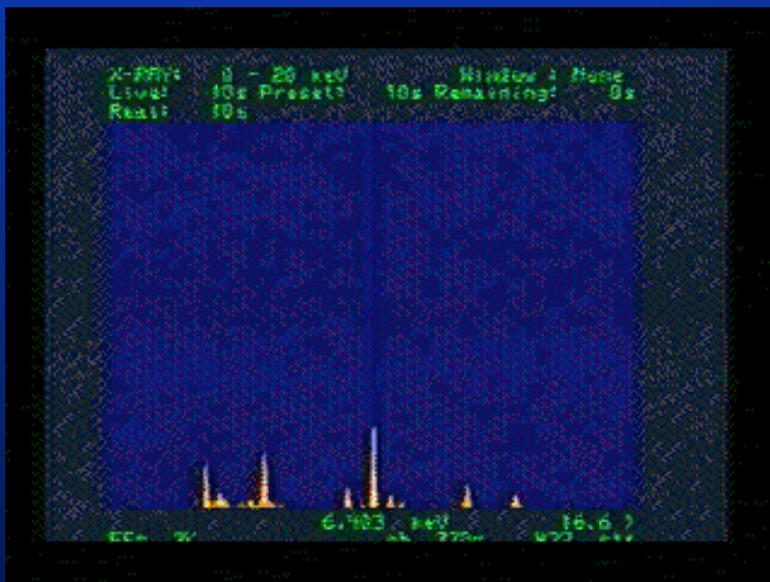
***TelePresence Microscopy, Collaboratories
and the DoE 2000 Program***

Challenges, Requirements , and Tools

***Nestor J. Zaluzec
Zaluzec@aaem.amc.anl.gov
<http://tpm.amc.anl.gov>***

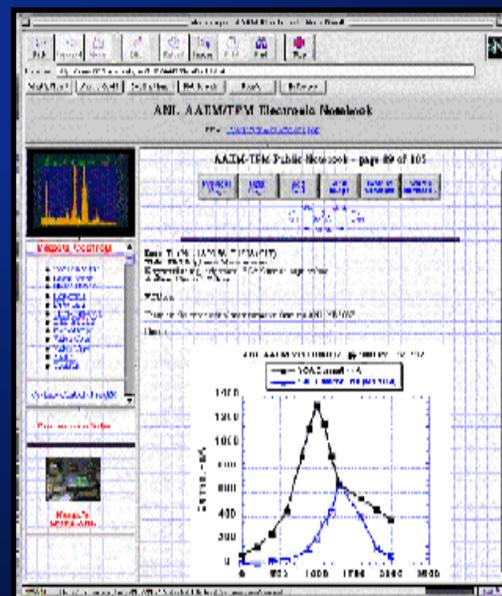
TelePresence Collaboration

- **Working with Data**
 - Real-Time Access to Current Results
 - Analysis Tools
 - High Performance Data Engines



TelePresence Collaboration

- **Working with Collaborators , Investigators Need to:**
 - Discuss the Experimental Progress
 - View Data While It is Being Acquired
 - Sketch Out Trends
 - Access Supporting Documentation



TelePresence Collaboration

The Challenge

Controls

Instrumentation, Data, Standards,
Legacy Platforms, Human Factors, Time, Budget



Input

- Users →
- Enablers →

- New Paradigm for Interactive R&D and Education →
- →

Output



Networks, Servers,
Browsers, Tools

Mechanisms

Functional Requirements for Collaboration

Key Issues

Collaboration Functions

Virtual Workspace

- Real Time Data
- Asynchronous Data
- Observation Areas
- Private Meeting Rooms

Digital Media Sharing

Tele/Video Conferencing

Data Sharing

Library/References/Archives

Application Sharing

- Data Analysis Tools

Persistence Functions

Data Archiving

Session Archiving

Electronic Notebooks

Data Mining

Device Interactions

Instrument Interface

Legacy Systems

Perphiperal Systems

Persistent Electronic Space

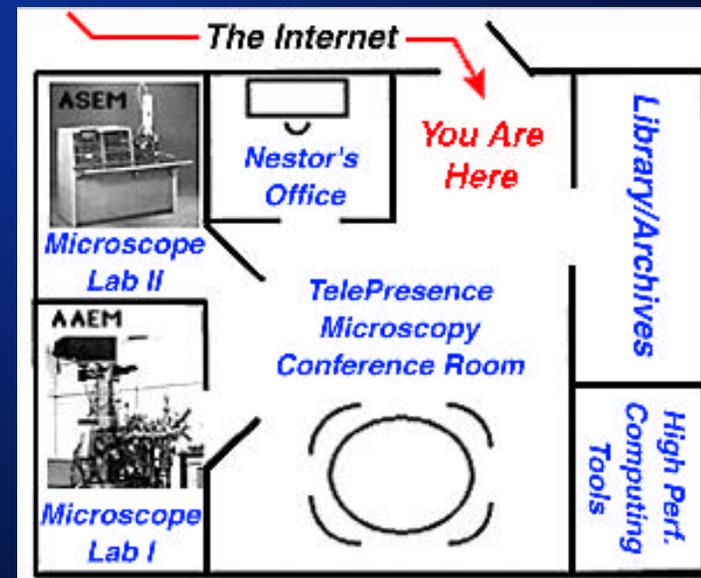
WWW Site is an Ideal Proto-type Model of a Persistent Electronic Space

- **Observational Modes**
- **Capabilities for both Dynamic and Static Data**
- **Can Host both Private and Public Areas**
- **Completely Digital Media**
- **A/V Compliant**
- **Enables Data Sharing with minimal work**
- **Extensible to Application Sharing**

Persistent Electronic Space

Characteristics of a Persistent Electronic “Lab”

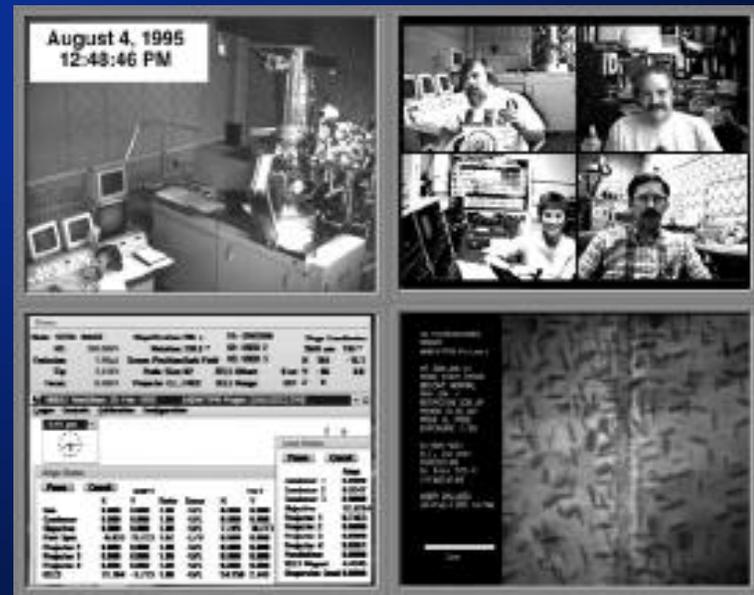
- Always There
- Collaboratory Interaction Zone
 - Offices, Work Areas, Labs, Mailboxes
- Access Control
 - Active
 - Public/Private/Restricted
 - Real Time Interactions
 - Editable
 - Passive
 - Public/Private/Restricted
 - Viewable not Editable
- Scalability



Sharable Entities

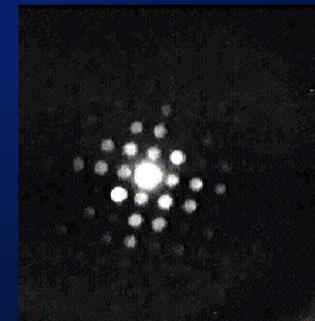
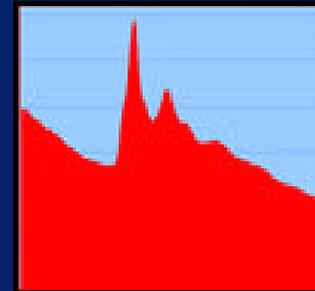
Items in the Collaboratory which may be “Sharable”

- People / Expertise
 - On-Line Expertise & Knowledge -> Non-Linear Interaction
- Data
 - Text/Graphics Documents
 - Images, Spectra
- Instrumentation
- Application Programs
- Sessions



Sharing Techniques

- **Laboratory/Office Environment**
 - Tele - Video Conferencing
 - Lab Environment
 - Instrumentation
- **Fixed Data**
 - Items which do not change with Time
 - Archived Text, Graphics....
 - Archived Data Sets
- **Time Sensitive Data**
 - Real Time Images / Spectra
 - Real Time Analyses
 - Real Time Documents



Session Control / Discovery

- ***Session Control***
 - How big is the Collaboratory / User Base
 - Access Levels (Administrative/Security)
 - Must not get in the way of doing work.
 - Access Control Lists (ACL)- passwords
 - User Certificates - Encrypted Keys
- ***Discovery***
 - Searchable for the Various Sharable Entities
 - State Sensitive
 - Changes with the availability of the Entity
 - Changes with access control levels
 - Directory Services

Microanalysis & Materials Research

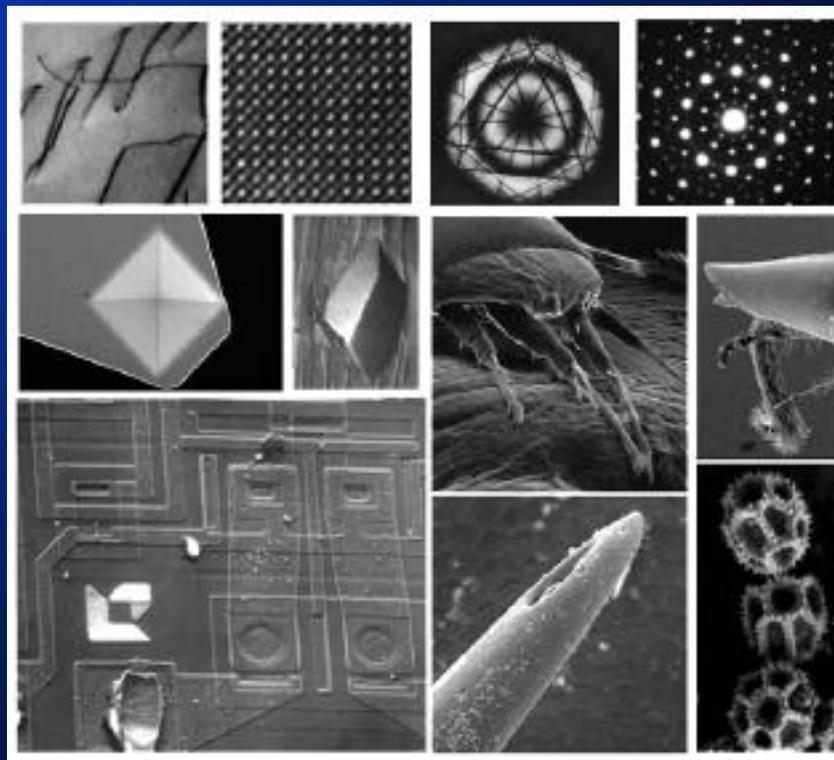
Materials Science

Determine the relationship of Structure to Properties, because the macroscopic properties of any material can be ultimately traced to the synergistic relationships of its constituent phases and any defect structures contained therein.

Microscopy/Microanalysis

Methodologies used to determine the structure of matter at a resolution better than that of the unaided eye using photons, charged particles, or mechanical probes.

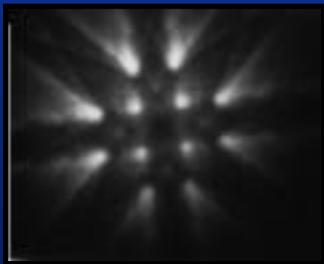
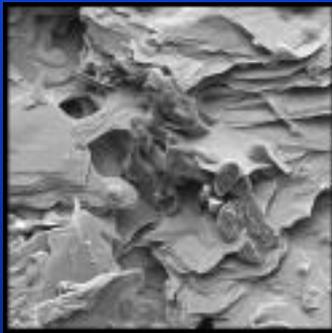
- Morphology
- Crystallography
- Elemental Composition
- Chemical Composition
- Electronic Structure



MicroCharacterization via Electron Microscopy

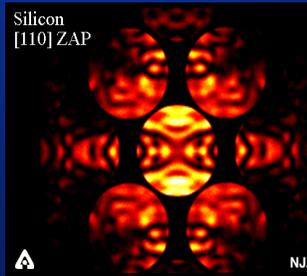
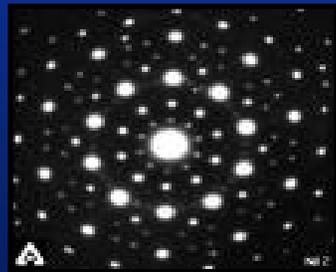
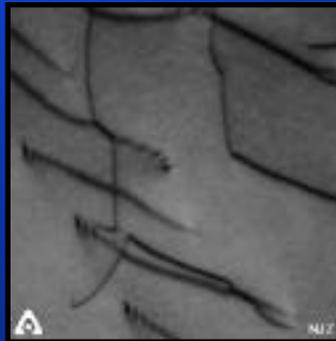
SEM

Scanning Electron Microscopy



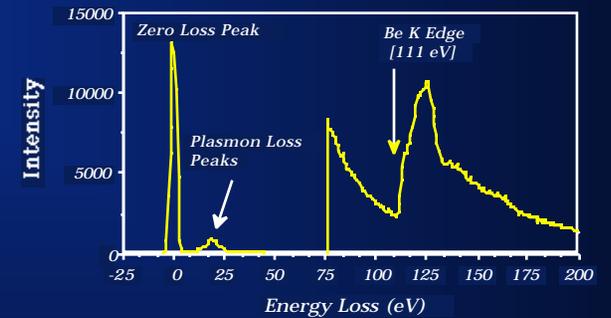
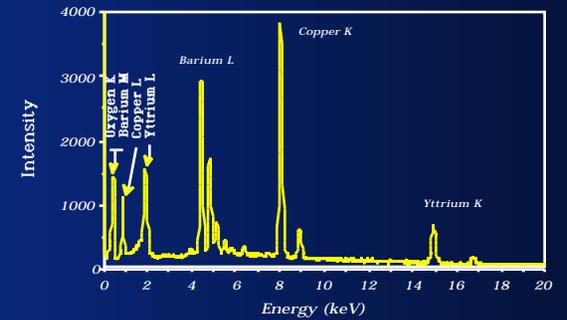
TEM - STEM - HREM

Transmission - Scanning Transmission -
High Resolution Electron Microscopy



AEM

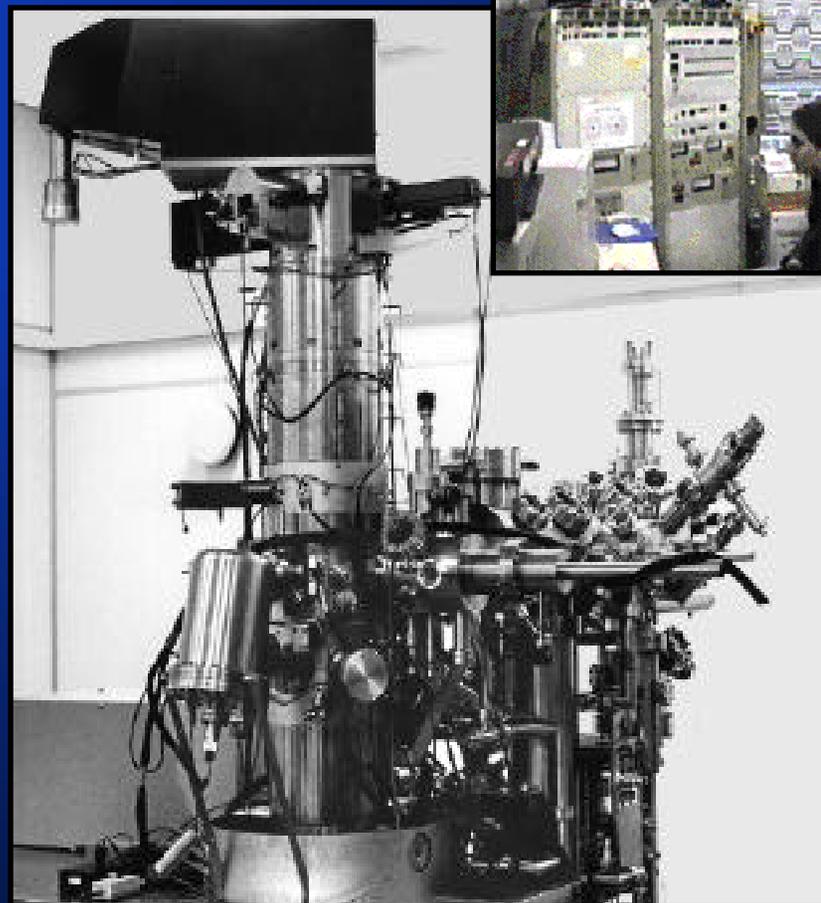
Analytical Electron
Microscopy



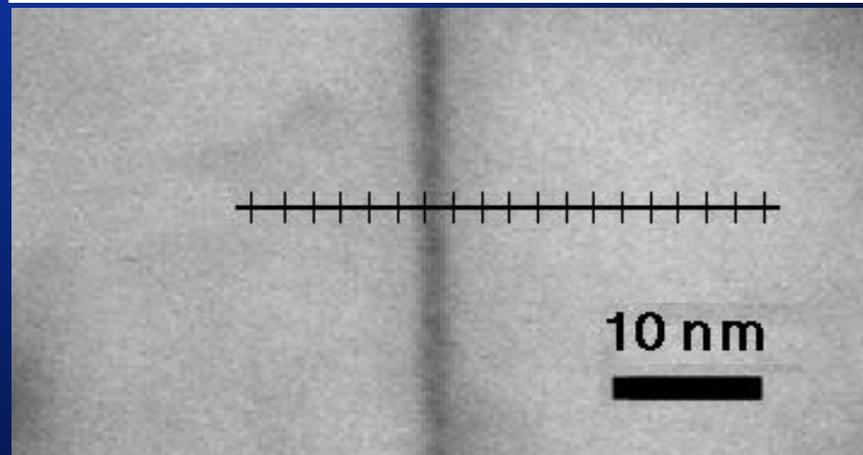
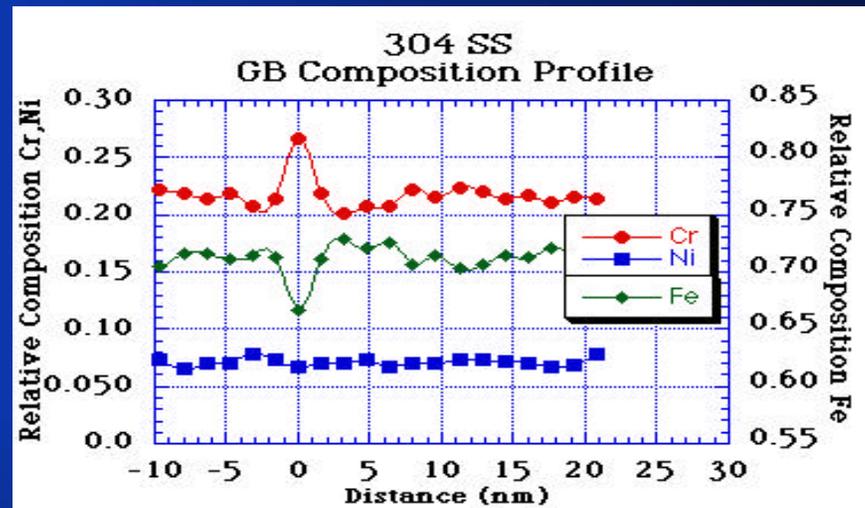
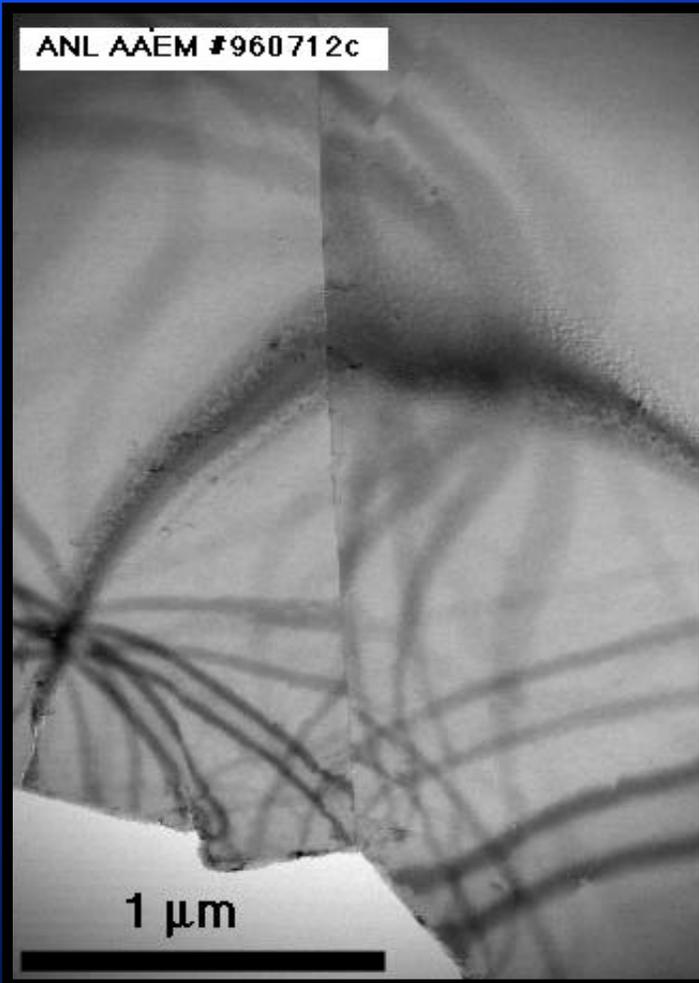
Morphology, Crystallography, Elemental, Chemical, Electronic Structure

ANL - Advanced Analytical Electron Microscope

- **Cold Field Emission Electron Source**
 - V_0 : 50 - 300 kV
- **Ultrahigh vacuum (UHV) environment**
 - $\sim 1 \times 10^{-11}$ torr - Gun, $< 2 \times 10^{-10}$ torr - Column
 - $< 5 \times 10^{-10}$ torr - Specimen Preparation Chamber
- **Electron Optics capable of :**
 - STEM / SEM:
 - TEM:
 - CBED/SAED:
 - Other Modes: TSEM, TSED, RHEED
- **Side Entry Goniometer Stages**
 - RT Double Tilt Beryllium:
 - LN2 Cooled Double Tilt Be Stage:
 - Single Tilt Heating Stage:
- **Analytical SubSystems on the E/O Column**
 - XEDS , EELS, AES
- **Specimen Preparation Chamber**
 - High Pressure/Temperature Gas Reaction Cell
 - Thin Film Evaporation Chamber
 - Mini-SIMS system - Gallium LMIS, Quad Mass Analyzer
 - RV LEED & Vacuum Transfer Vessel
 - ANL MultiPort Station for development work.
- **Computer Control**
- **Special Objective Lens Port Configuration**
 - 7 Experimental Ports on Objective Lens for Analytical Equipment
 - 3 Additional Ports for Electrical Feedthrus etc...



High Spatial Resolution Measurements of GB Segregation for IASCC Studies in 304 /316 SS



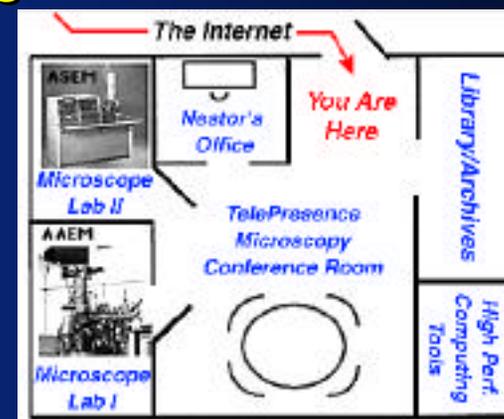
TelePresence Microscopy Collaboratory

- Create a Persistent Virtual Location around Centers of Scientific Interest
- Integrate Operation & Control of Scientific Experiments

Allow **Remote Users** to have either **passive** or **active** participation to experimentation with access to both **Expertise and Instrumentation**

via a platform independent GUI

- Experimental Windows, Electronic Notebooks
 - Meeting Rooms/Offices/ TeleConference Links
 - Libraries/Data Archives
 - Access to High Performance Data Engines for data processing
- Provide Opportunities for Distance Learning and Remote Collaboration at all levels
 - Research and Industrial Collaborations
 - Middle / High / and University Levels
 - Provides a set of requirements which taxes the limits of the Internet
Imaging, Spectroscopy, Real-Time Control, Conferencing,



TelePresence Microscopy Collaboratory Architecture

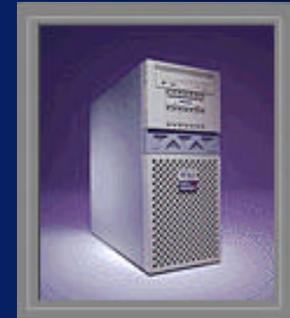


User Workstation



Internet

Collaboratory Server



Resource:
Instrumentation,
Data, Expertise

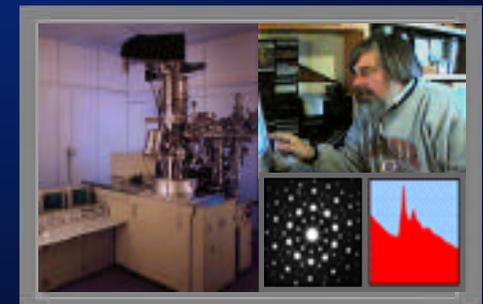
Inter-System Communications



Control Systems



Interface Electronics



TPM Collaboration Demographics

Organization	Edu 51%	Com 24%	Gov 19%	Org 3%	Individuals 3%
Location	USA 67%	Rest of the World 33%			
Platform:	USA Only	World Wide		Operating Systems	
PC Based	206 (41%)	293 (47%)		Win 95 (~98%), Win NT(<1%), Win 3.1(<1%) OS/2 (<1%) Mac OS V 7.5xx (100%)	
Mac Based	251 (49%)	279 (45%)			
Unix Based				Solaris	
SUN	32 (~6%)	36 (~6%)		Note: 2 sites account for 20 systems!	
SGI	9 (~2%)	10 (~2%)		SGI	
IBM RS	6 (~1%)	6 (~1%)		not specified	
DEC	2 (<1%)	2 (<1%)		not specified	
HP	1 (<<1%)	1 (<<1%)		not specified	
NEXT	1 (<<1%)	1 (<<1%)		Next	
Total CPU's	508	628			

Fall -1997

TPM Collaboration Demographics

	Edu	Com	Gov	Org	Individuals
Organization	51%	24%	19%	3%	3%
Location	USA		Rest of the World		Totals
CPU's	67%		33%		100%
	508 (81%)		120 (19%)		628 (100%)
Internet Connection	Modem 13(13%)	ISDN 7(7%)	\geq T1 28(28%)	SiteWide (Speed Unknown) 51(52%)	
Firewall On-Site		Yes 26%	No or Unknown 74%		
Video Conferencing	CuSeeMe 17	Intel ProShare 3	PicTel 3	Vic/Vat 2	All Others 3
Browser	NetScape 87%		MicroSoft IE 12%		All Others 3%
	(some sites run multiple types of browsers hence totals exceed 100%)				

TelePresence Microscopy

Provides Access to:

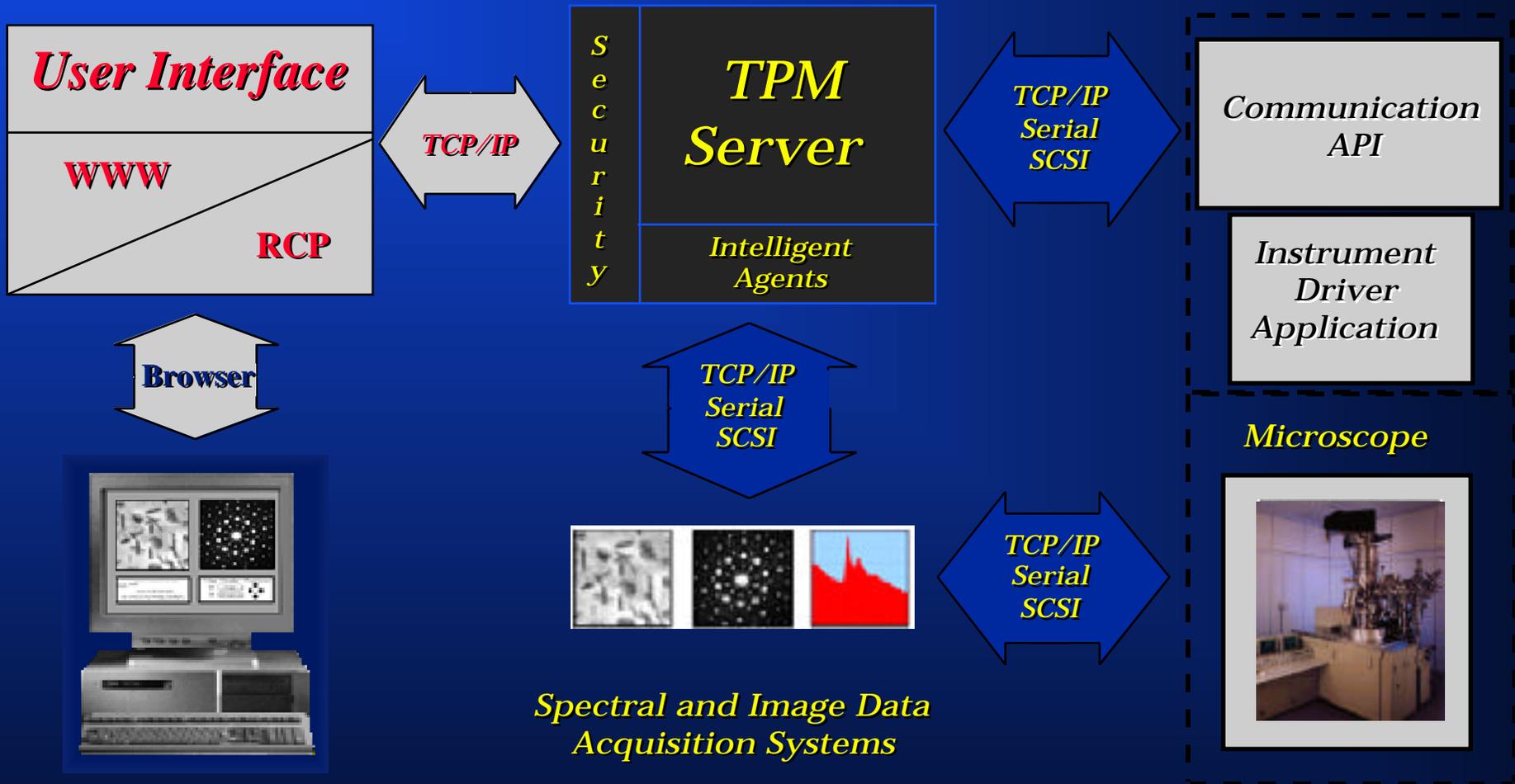
- Instrument Room
- Instrument Status
- Experimental Data
- On-Line Control
- Video Conferencing
- Electronic Notebooks

August 4, 1995
12:48:46 PM

Param.	Control	Value	Status	Group	Unit	Value	Unit
Gun		0.000	0.000	1.000	-OFF	0.000	0.000
Condenser		0.000	0.000	1.000	-OFF	0.000	0.000
Objective		0.000	0.000	1.000	-OFF	2.250	10.170
Post Spec		-6.832	15.723	1.600	-L70	0.000	0.000
Projector 1		0.000	0.000	1.000	-OFF	0.000	0.000
Projector 2		0.000	0.000	1.000	-OFF	0.000	0.000
Projector 3		0.000	0.000	1.000	-OFF	0.000	0.000
Projector 4		0.000	0.000	1.000	-OFF	0.000	0.000
BEELS		20.504	-5.773	1.000	-OFF	34.750	2.441

UG MICROSCOPES
HE603
PHOT-TM Project
HT 200.00 kV
MODE STEM IMAGE
BRIGHT 1000VL
PHOT 200.00
ROTATION 300.4P
PHOT 012C 42
PHOT CL. FREE
EXPOSURE 1.30
R#-001-001
R.L.J. DYNAMIC
8/4/95-01
R# 1004 S75 C
Irradiated
USER ZHALZEC
20-Feb-1995 14:58
1um

Current Architecture Instrument Access/Control



ANL - WWW TPM Server

Provides
Platform
Independent
Access

Netscape:ANL TPM Site Frames Version

Location: <http://tpm.jano.anl.gov/TPMVideo.html>

What's New? What's Cool? Definitions Net Search People Software

AAEM TelePresence Microscopy Site Materials MicroCharacterization Collaboratory

Visitor Number **30749** since Aug. 1, 1996



1 fps 5 fps 10 fps 15 fps 30 fps

Collaborator: Ron Anderson, Michael Porisk, Samuel Jones, Joly Bonkshti, Nestor Salazar
Organization: IBM, NIST, St. Dominic School, ANL
Specimen: 1654 Mbyte DEAM case 1994
Experiment: Technology Review
Status: The Microscope is **On-LINE** Mode.
Messages: Objective Lens control has been completed. Nestor

General Information

- Switch to **Collaboratory Mode**: Select the Partner:
 - [ANL & NIST](#)
 - [ANL & University of Illinois](#)
 - [ANL & ORNL](#)
 - [ANL & HCEM/ENL](#)
- Gen. Info. about [TelePresence Microscopy](#)
- Get information about [Live Video Conferencing](#)
- [DoX 2000 Materials MicroCharacterization Collaboratory](#)
- Will you [Use Operations on web](#) / [Comments](#) about TPM and/or this

User Functions

[AAEM/TPM Electronic Notebook](#)

- [Full Screen Display Mode](#)
- [Online Microscope Controls](#)

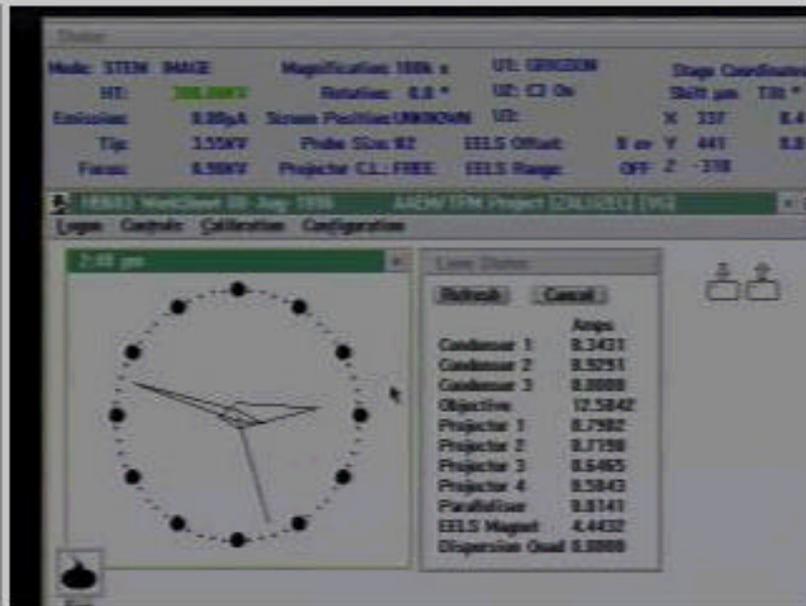
Use Multi-Function Control Panel
Authorized UserID and Password Required

Login Select

Use the Navigation Buttons to Select Data View

	Operator's Console		Status Screen
	AAEM Room View		Detector No. 1
	MacroScope		Detector No. 2
	Video Conf. Screen		TEM-DFIT-CCD Detector
	Video Taped Session		XEDS/EELS Spectrometers
	ASEM Room		N/JZ Software Toolkit

298K read @ 18.7K/sec



**On-Line
Instrument
Control**

**Platform
Independent
WWW
Interface**

Netscape: VG 603z Novice User Control Panel

Back Forward Home Edit Reload Images Print Find Stop

Location: <http://tpm.amc.anl.gov>

ANL TelePresence Microscopy Site
On-Line User Access Enabled

VG MICROSCOPES
HBE03
AAEM/TPM Project
HT 300.05KV
MODE STEM IMAGE
BRIGHT NORMAL
MAG 500x
ROTATION 0.0
PROBE SIZE #2
PROJ CL FREE
EXPOSURE 8.75

USER ZALLUDEC VGM
11-Jun-1997 01:20

40nm

Specimen Stage Control

Shift Height Tilt

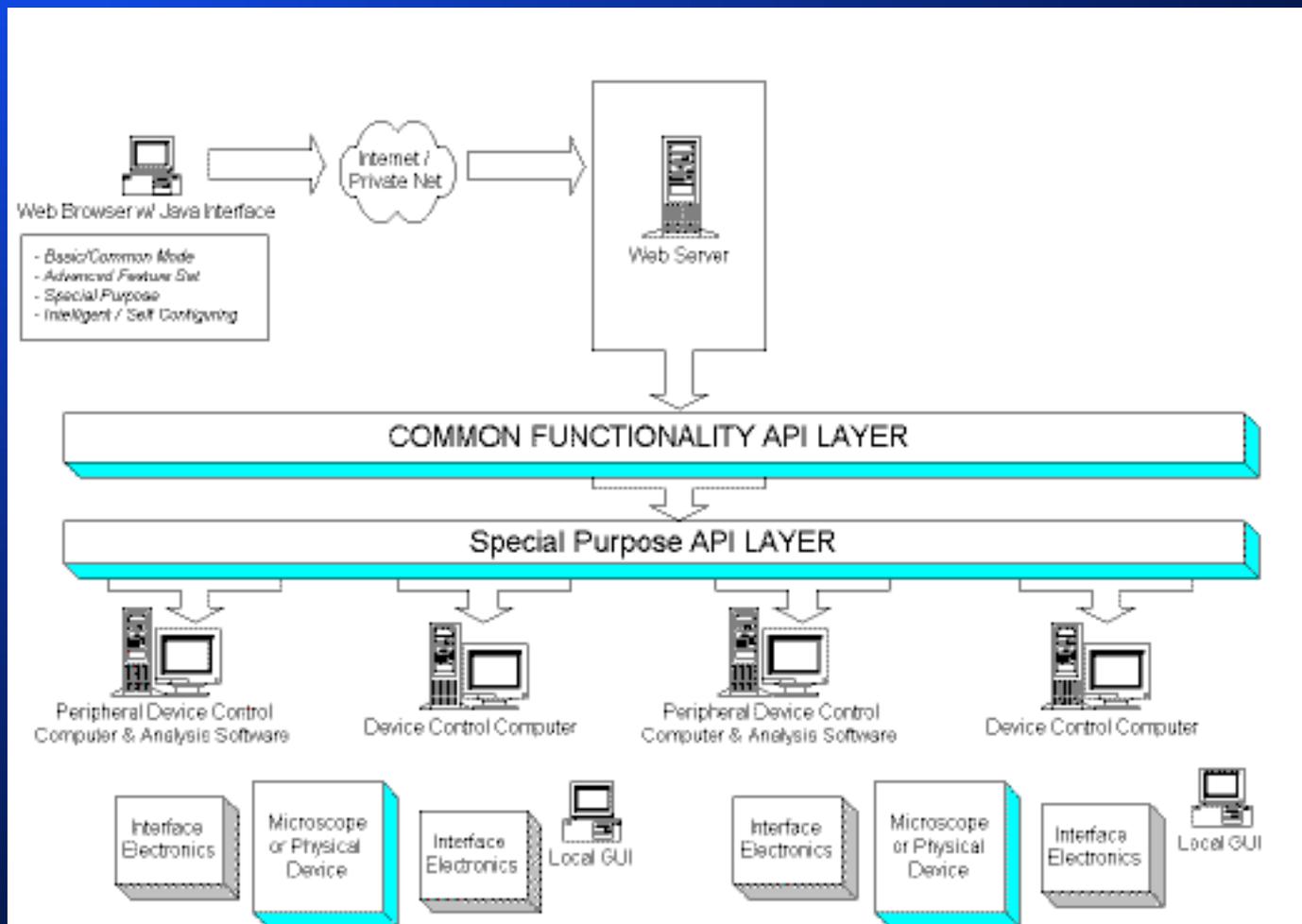
Scan Control	Microscope Control	Mi sc. Ut i l.	Data Display
TV	MAG +	Console	Status
FAST	MAG -	Room	BF Det.
SLOW	Focus +	MacroSc	DF Det.
<input type="checkbox"/> F.Scn	Focus -	Store	Spectr.
<input type="checkbox"/> R.Scn	NoteBk	Recall	CCD

User Status = Novice Level

[TPM Microscope](#) [AAEM/TPM Electronic NoteBook](#)

679K read (at 30.9K/sec)

Hardware Architecture



**On-Line
Instrument
Control**

**Platform
Independent
WWW
Interface**

Netscape: TelePresence Spectroscopy Remote XEDS/EELS Control

Location: <http://tpm.amc.anl.gov/cgi-bin/TPS.pl>

AAEM/TPM Project

TelePresence Spectroscopy Mode

at Argonne National Laboratory

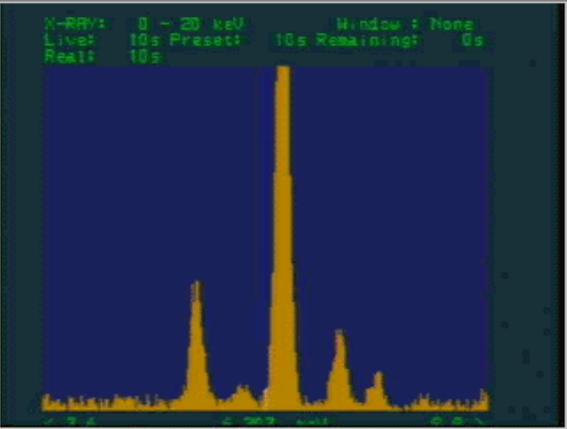
AAEM BF/DF Image

Microscope is currently **Off Line**



X-ray / Electron Spectrometer

Dimmed Spectroscopy Controls are **Off Line**



Shift Specimen:  MAG + Focus + BF Det. MAG - Focus - DF Det.

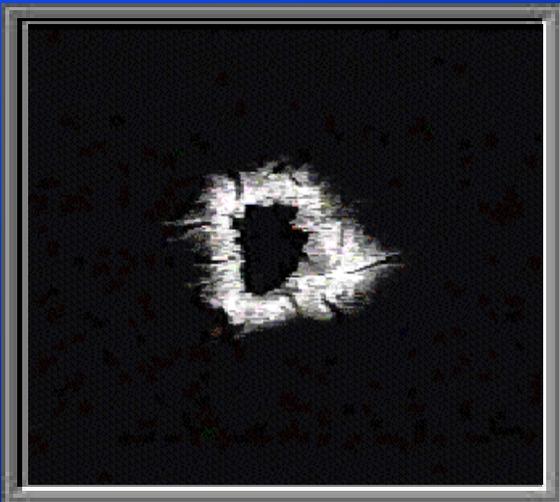
Spectrometer Controls: Start Clear ← → Stop OverLay → ← 

Return to Standard TPM Operating Mode

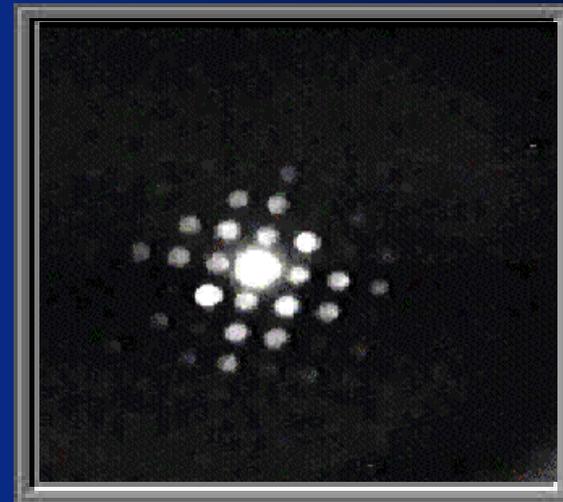
[20" Screen Low Res](#) [17" Screen Low Res](#) [14" Screen Low Res](#)

287K read (at 24.0K/sec)

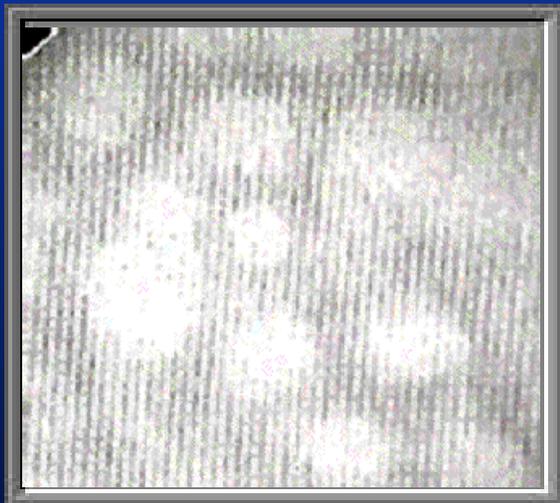
TelePresence Microscopy Remote Operations



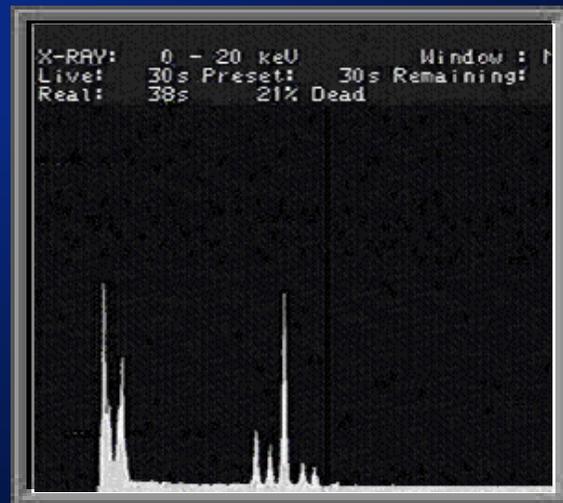
Conventional
Imaging



Diffraction

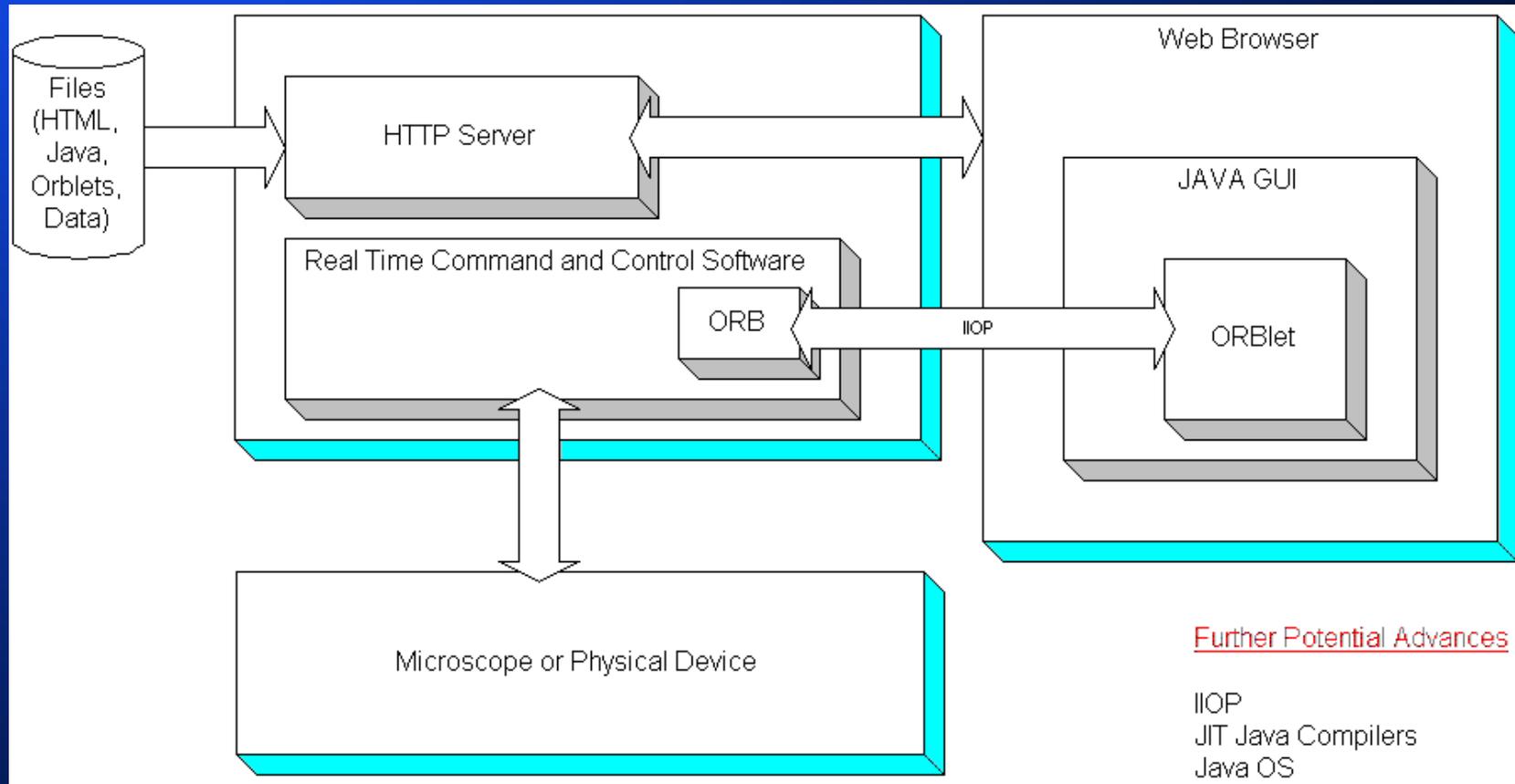


High
Resolution
Imaging



Spectroscopy

Next Generation: Software Architecture



Persistent Electronic Space Tools

An **Electronic Notebook** is a repository for objects that document scientific research.

Input Data
Retrieve Data
Query Data

Basic objects are: text, numerical data, images , drawings

Persistent Electronic Space Tools

Why an Electronic Notebook?

- ⇒ **Virtual Laboratories encourage shared remote access to expensive, one-of-a-kind / state-of-the-art resources.**
- ⇒ **Remote control of scientific instruments logically requires on-line documentation of capabilities and data.**
- ⇒ **Collaboration of distributed researchers is enhanced by a common record keeping device.**

Notebook Architecture

WWW - User Interface



Submit / Retrieve Requests

NoteBook Engine

CGI
Java, Perl

Input Modules

Text
Forms
HTML Editors
Java Applets
Live Data

Storage

Flat File Storage
Store
Retrieve
Time Stamped

TelePresence Microscopy

Electronic NoteBooks

**On-Line
Data Sharing
and
Collaboration**

Netscape: AAEM Electronic Notebook

Location: <http://tpm.amc.anl.gov/AAEMNoteBook.html>

ANL AAEM/TPM Electronic Notebook

[EMail: Zeluzec@amc.anl.gov](mailto:Zeluzec@amc.anl.gov)

AAEM-TPM Public Notebook - page 8 of 97

[Previous Page](#) [Next Page](#) [Add Text](#) [Add Image](#) [Table of Contents](#) [Search Notebook](#)

ANL LBNL
U. of T. M² NIST
OPRL

Camera Control

- Console View
- Room View
- Status Screen
- Device 1
- Device 2
- TPM-Dir-CCP
- XDC/SBELS
- MacroScope
- Filter Control
- Filter Type
- SSIM

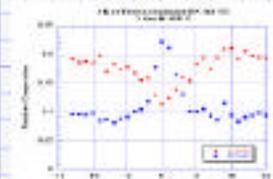
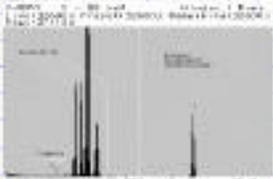
[TPM Home Page](#)

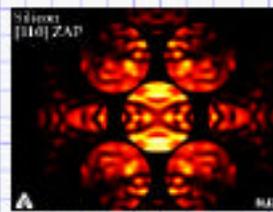
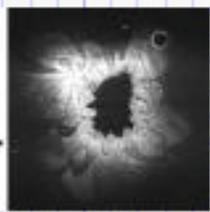
Conference Sites


Nester's Office-ANL

Date: Wed Mar 19 03:03:45 1997 (GMT)
Title: Resized Images 160 x 120
Keywords: images
Author: Nester J. Zeluzec

How let's look at downloaded images, all four images (160x120) on one page. Remember I'm resizing in the browser so the local CPU is handling the resizing of the original images all of which are 640x480.

2044K read (at 33.5K/sec)

Imaging over the Net : Bandwidth Issues

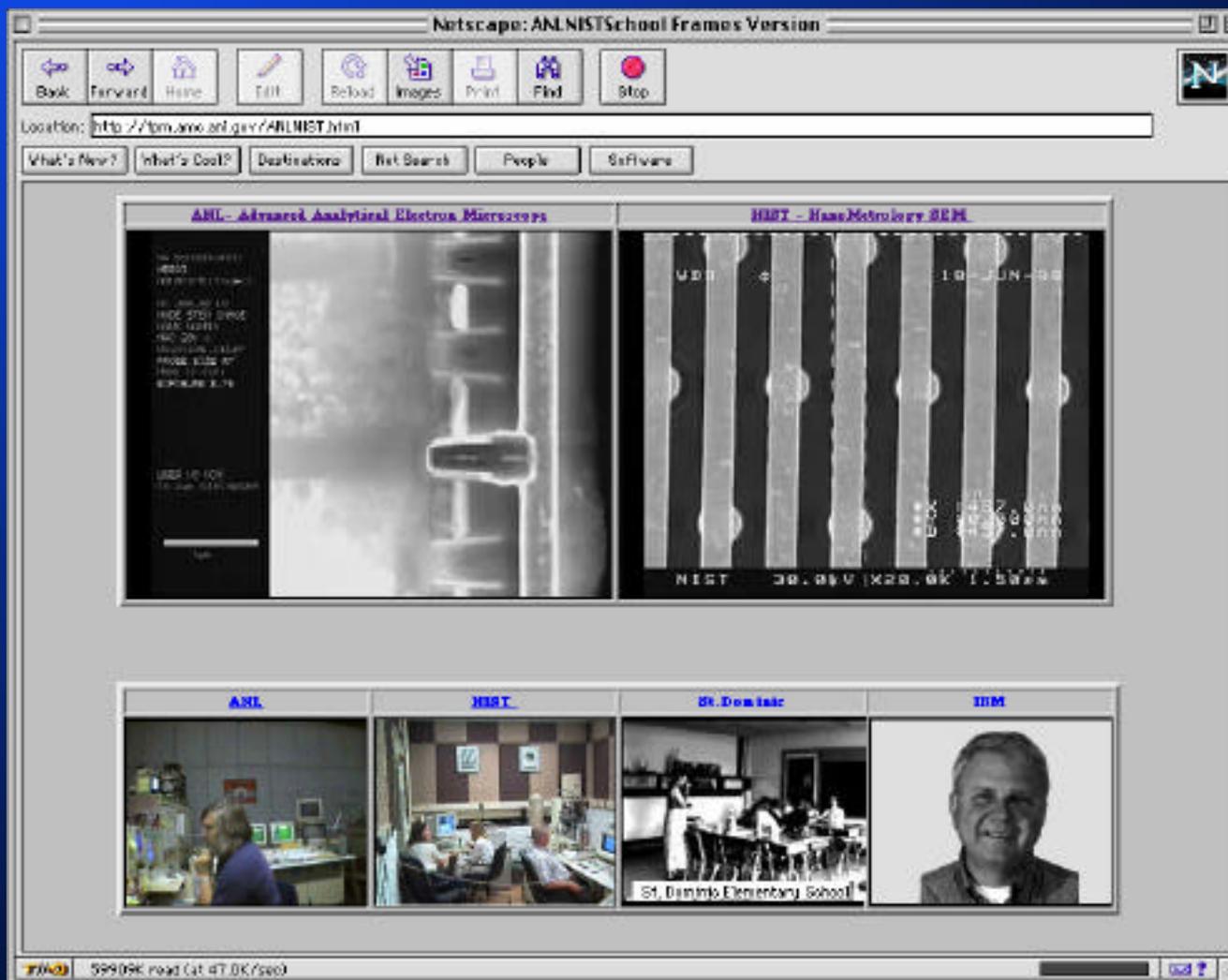
Maximum Aggregated Frames per Second 640x480 Image

<i>JPEG Quality</i>	<i>Bandwidth</i>					
	<i>28.8 Kbps</i>	<i>56Kbps</i>	<i>1.5 Mbps</i>	<i>10 Mbps</i>	<i>45 Mbps</i>	<i>100Mbps</i>
10	1.03	2.51	69	449	2018	4485
20	0.88	2.14	59	382	1721	3824
30	0.77	1.87	51	333	1500	3332
40	0.68	1.65	45	295	1329	2953
50	0.61	1.48	41	265	1193	2651
60	0.55	1.35	37	240	1082	2405
70	0.51	1.23	34	220	990	2021
80	0.47	1.14	31	202	913	2028
90	0.32	0.78	22	140	629	1367
100	0.13	0.31	9	56	251	557

Middle/High School Collaboratories



Middle/High School Collaboratories



DOE 2000 Goals

- ***Improved ability to solve DOE's complex scientific problems***
- ***Increased R&D productivity and efficiency***
- ***Enhanced access to DOE resources by R&D partners***

DOE 2000 National Collaboratories

- ***Put unique or expensive DOE research facilities on the internet for remote collaboration, experimentation, production, or measurement.***
- ***Provide collaborative tools: videoconferencing, shared electronic notebooks, shared whiteboards, shared document creation, shared data-viewing and analysis tools.***
- ***Provide tools for sharing and integrating DOE scientific information.***

DOE 2000 Program Components

- ***Advanced Computational Testing and Simulation***
- ***Collaboratory Technology Research Projects***
- ***Collaboratory Pilot Projects***

DOE 2000 Technology Research & Development Projects

- ***Collaborative Integration Framework***
- ***Electronic Notebooks***
- ***Collaborative Session Management***
- ***Shared Virtual Spaces***
- ***Scalable Security Architecture***
- ***ESnet Quality of Service***
- ***Floor Control***

DOE 2000 Collaboratory Pilot Projects

- ***The Diesel Combustion Collaboratory***
 - **Science Area:** Diesel engine emissions control
 - **Partners:** SNL, LBNL, LLNL, Univ. of Wisc.
 - **Industrial Partners:** Cummins Engine Co.; Caterpillar, Inc.; Detroit Diesel
- ***The Materials MicroCharacterization Collaboratory (MMC)***
 - **Science Area:** Microstructure of technologically advanced materials, with focus on interface characterization
 - **Partners:** ORNL, LBNL, ANL, NIST, Univ. of Illinois
 - **Industrial Partners:** Gatan, Inc.; RJ Lee Instruments Ltd.; EMI SPEC Systems, Inc.; Philips Electron Optics; NSA - Hitachi Scientific Instruments; JEOL USA, Inc.; Sun Microsystems, Inc.; Graham Technology Solutions, Inc.

DOE 2000



URL: <http://tpm.amc.anl.gov/MMC>

E-Mail: MMC@aaem.amc.anl.gov

MMC Goals

- To extend, improve and mold the electronic laboratory environments already in place at each of these Centers into a single cohesive virtual laboratory, accessible from anywhere on the Internet.
- To use the extended capabilities of the virtual Collaboratory to address materials sciences research problems related to interfaces and surfaces in economically important materials of interest to DOE programs.
- To develop a functional, interactive electronic collaboratory having the necessary tools for operation by the microanalysis community; *leading to a truly new paradigm in scientific research.*

Materials MicroCharacterization Collaboratory

Materials MicroCharacterization Collaboratory

TelePresence Microscopy Facilities

ARGONNE
NATIONAL LABORATORY



NIST

ornl

University of Illinois
Urbana-Champaign

[ANL](#)



[NIST](#)



[Univ. of Illinois](#)



[ORNL](#)



[NCEM/LBNL](#)



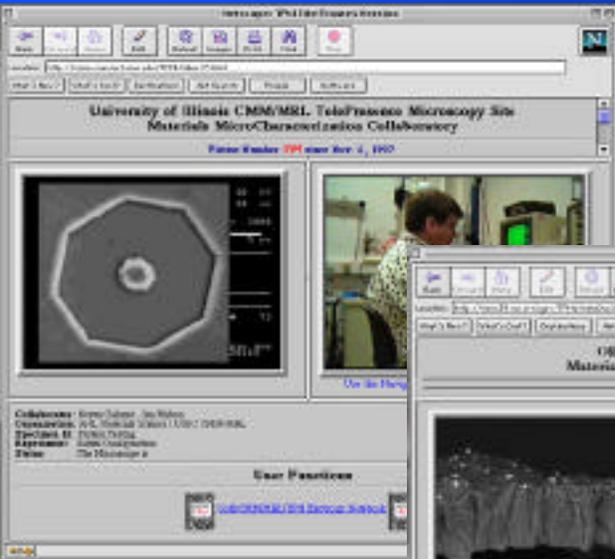
Non WWW-Solutions

Other Methods of TelePresence
Operation

[LBNL - ITG](#)
[ORNL - MAUC](#)

<http://tpm.amc.anl.gov/mmc>

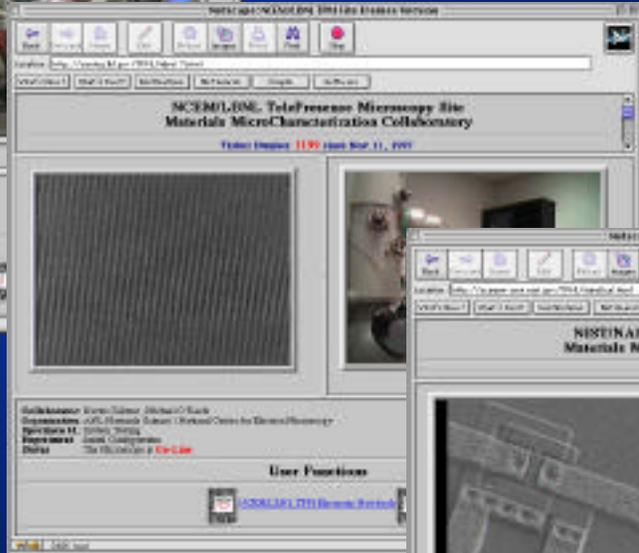
Materials MicroCharacterization Collaboratory



Univ. of Illinois



ORNL



LBNL



NIST



ANL

MultiSite Collaboration

The screenshot shows a web browser window titled "TPM Site Frames Version - Netscape". The address bar contains "http://www.ansc.ansl.gov/TPM/CollabMIST.html". The page content is titled "Materials MicroCharacterization Collaboratory - TPM Site".

The main content area is divided into two columns:

- ANL:** Features an "Advanced Analytical Electron Microscope" image showing a sample and a person operating the equipment.
- NIST:** Features a "NanoTechnology SEM" image showing a sample.

Below the images are two control panels:

- Left Panel:** Includes buttons for "Operator's Console", "AAEM Room View", "MacroScope", "Video Cont. Screen", "Video Taped Session", "ASEM Room", "Status Screen", "Detector No. 1", "Detector No. 2", "TEM-DIR-CCD Detector", "XEDS Spectrometer", and "EELS Spectrograph".
- Right Panel:** Includes buttons for "Operator's Console", "AAEM Room View", "MacroScope", "Video Cont. Screen", "Video Taped Session", "ASEM Room", "Status Screen", "Detector No. 1", "Detector No. 2", "TEM-DIR-CCD Detector", "XEDS Spectrometer", and "EELS Spectrograph".

A central text box states: "This site is under development (hence last word right?) but for the record and only Lurker Mode is available at moment. The image source selection, i.e."

A large red watermark is overlaid on the right control panel, reading "Public Control Currently Off - Line".

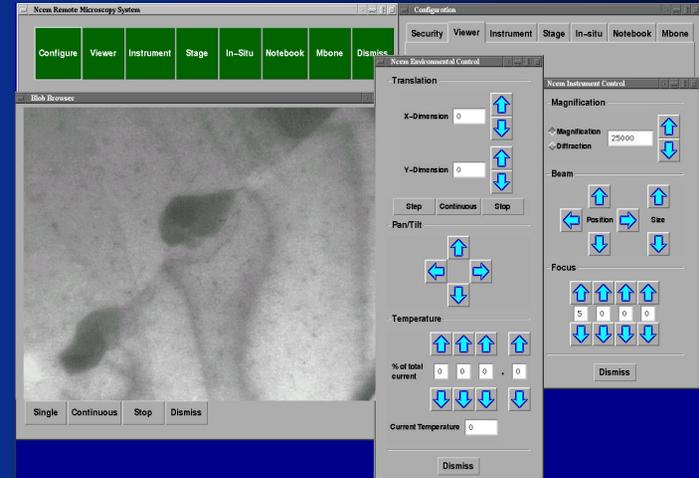
MMC Instrumentation Resources

Site	Instrument	Online	Uniqness	Vendor
ANL	Analytical SEM	WWW	SEM, Outreach	Philips
ANL	Advanced AEM	WWW & Java	HR AEM, EDS, EELS, AES	VG
LBNL	EM-1500	Custom Unix & Java	1.5 MV HVEM, <i>in situ</i>	Kratos
LBNL	CM300FEG	WWW	1Å resolution TEM	Philips
LBNL	DEC Alpha		Image Simulations	DEC
U of I	DSM-960	WWW	Analytical/Teaching SEM, EDS, cathodoluminescence, EBSP texture	Zeiss
U of I	S-4700	WWW	HR low voltage FEG-SEM, EDS	Hitachi
U of I	H-9000		HR TEM (300 kV)	Hitachi
U of I	LEEM		UHV Low Energy EM, <i>in situ</i> , UHV connection to EPI-Center	
NIST	S-4500	WWW	NanoMetrology	Hitachi
ORNL (EE)	HF-2000	Timbuktu & Digital MicroG	Holography, EFI, EDS, FEG TEM	Hitachi, Gatan
ORNL (EE)	S-4500	Timbuktu & Digital MicroG	HR-SEM, EDS	Hitachi, Gatan
ORNL (ER)	CM200FEG		FEG TEM, spectrum imaging	Philips, EMiSPEC
ORNL (ER)	XL30	WWW	FEG SEM, texture mapping, WDS/EDS	Philips
ORNL (ER)	SGI		3D atom probe visualization	SGI
ORNL (EE)	HFIR beamline	WWW LabView	Neutron diffraction	
ORNL (EE)	NSLS/APS beamlines		Xray diffraction	

One Solution is Not Always the Answer!

Lawrence Berkeley National Laboratory

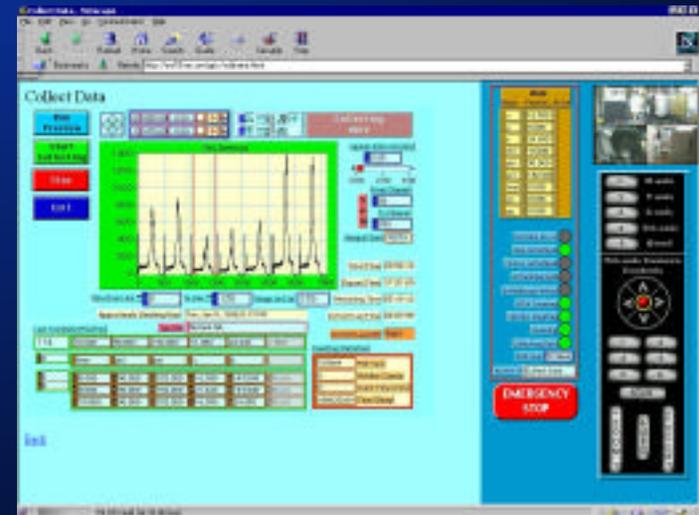
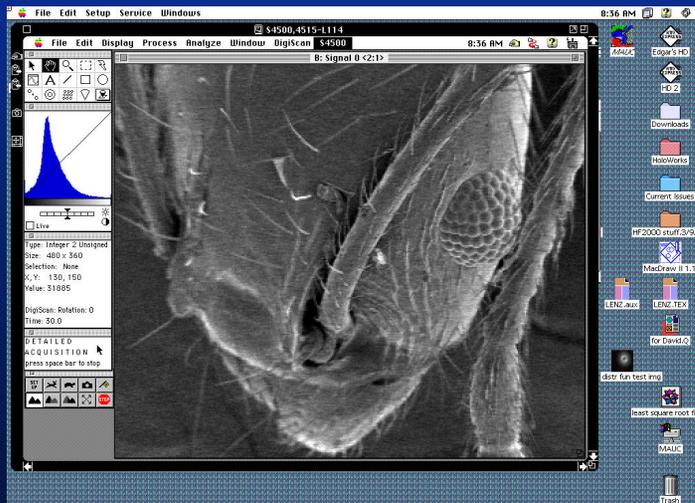
HVEM In-Situ Microscopy,
Unix Client/Server



Oak Ridge National Laboratory

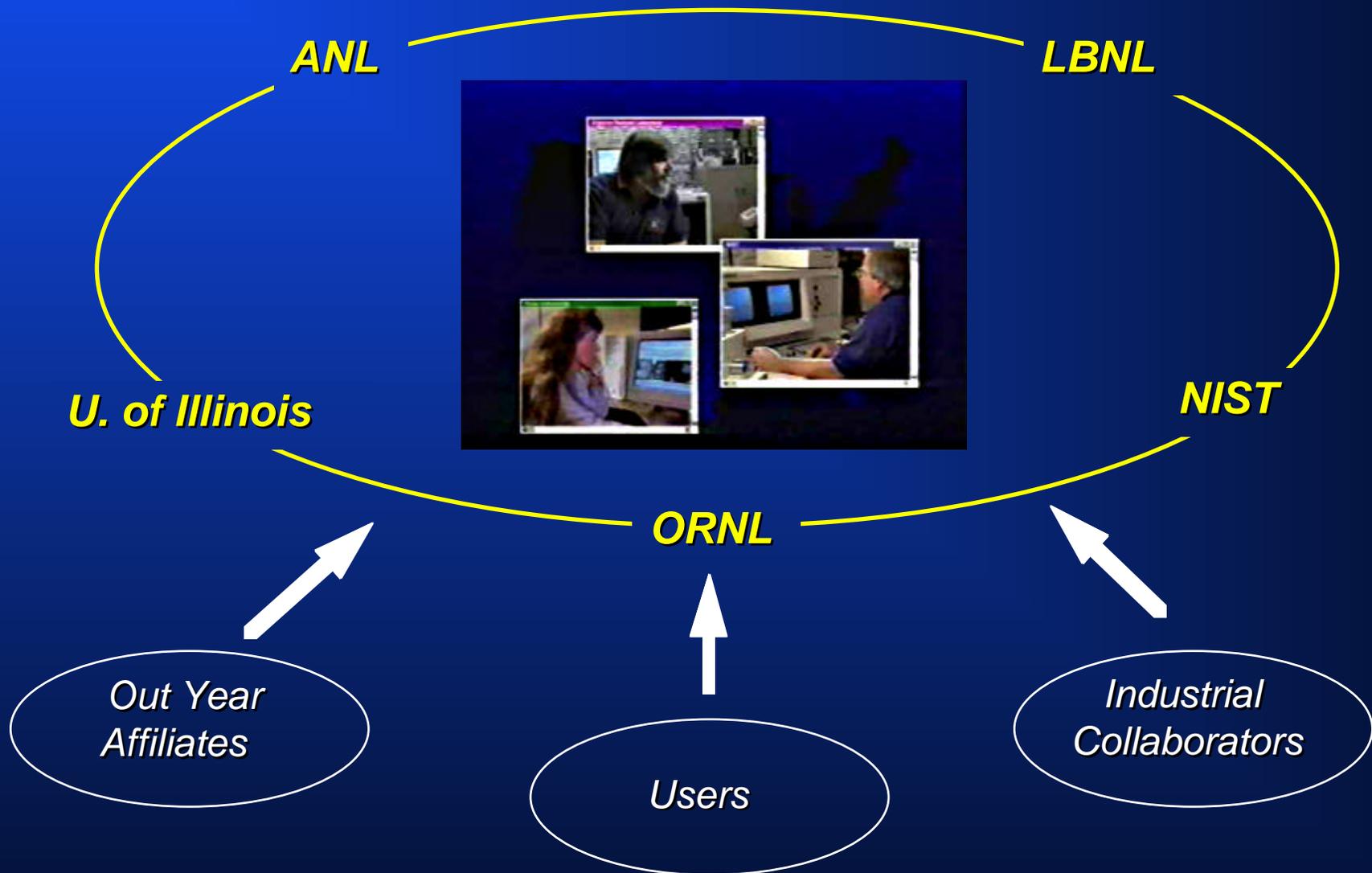
Remote Electron Microscopy - Mac, Timbuktu

Neutron Residual Stress Mapping Facility - PC, LabVIEW Client/Server



Argonne National Laboratory

Materials MicroCharacterization Collaboratory



MultiSite Collaboration



Netscape: TelePresence Spectroscopy Remote XEDS/EELS Control

Location: <http://tpes.ansc.anl.gov/TPS.pl>

AAEM/TPM Project
TelePresence Spectroscopy Mode
at Argonne National Laboratory

AAEM BF/DF Image	X-ray / Electron Spectrometer
Microscope is currently On Line	Controls are On Line
Shift Specimen	Spectrometer Controls
Microscope Controls	Shift Spectra

User Status = **Novice Level**

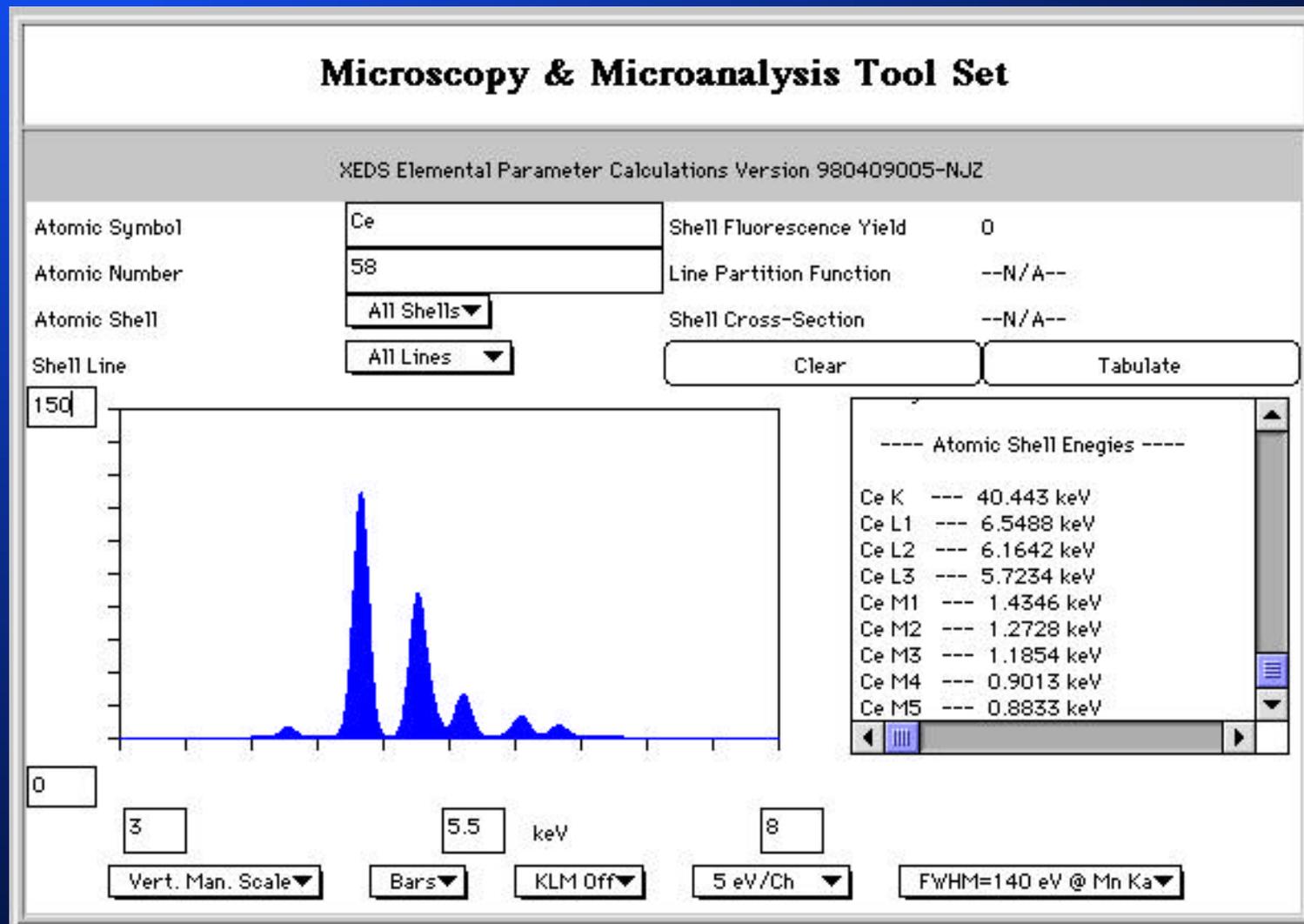
Return to Disabled TPM Operating Mode

20" Screen Low Res 17" Screen Low Res 14" Screen Low Res

Network Based Video Conferencing is Possible, but Immature



Java - Based Tools



Interactive Collaboratories

Collaboratories focus on *Resources* in an interactive persistent electronic space.

In the MMC / TPM Collaboratory we are exploring and developing an electronic virtual environment equipped with state-of-the-art resources (consisting of both expertise as well as instrumentation) which revolves around a common theme of Microscopy and Microanalysis applied to both Education and Research.

Interactive Collaboratories

By placing creative scientists having varying yet complementary expertise together in a new environment which allows convenient, rapid and dynamic interactions to flow unencumbered by the limits of time and distance, we expect to not only foster, but enhance, the ability of these individuals to conceive and execute scientific research.

It is essential to remember that, at the end of the day, it is not the instrumentation which produces the science but rather the individuals who formulate and execute experiments designed and carried out using the "tools" which they have at their disposal.

Acknowledgements

Funding: U.S. DoE (BES,OTT, MICS) & ANL, NIST

Collaborators:

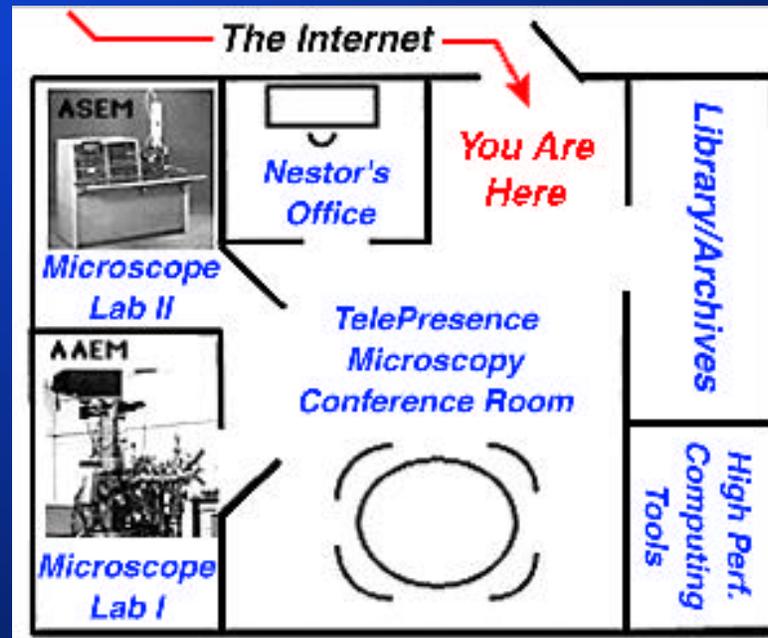
MMC: K. Alexander, E. Voelkl, M. Wright, M.Postek,
M. O'Keefe, J. Mabon

DoE2000: R. Stevens, A. Geist, N. Nachtigal, D. Agarwald

MMC Industrial:

Philips Electronic Inst., Hitachi Scientific Inst.,
JEOL-USA, R.J. Lee, Gatan Inc, EMiSpec Inc,
Sun MicroSystems, Graham Technology

TelePresence Microscopy Collaboratory



<http://tpm.amc.anl.gov>

Accessing the TPM Collaboratory from your DeskTop Computer

- **Install a copy of NetScape Version 2.0 or 3.0 on your Computer**
 - The TPM Server software is computer platform independent you may use any **Macintosh, Intel/PC, or Unix** computer. The faster your CPU the better the performance, a high resolution 17" (800 x 600 pixel) monitor is recommended but not required.
 - Microsoft *Internet Explorer (IE)* **software is not compatible** with the TPM server
- **Using your WWW Browser login to the TPM Public Site**
 - <http://tpm.amc.anl.gov>
 - Use the fastest connection to the Internet you can obtain
 - Fast Modems are usable but not recommended
 - ISDN is acceptable, T1 connections are fine
- **To Operate the Microscope over the Internet**
 - You must login to the TPM Private Site.
 - This requires authorization and is password protected.
 - Video Conferencing software is recommended but not necessary a Telephone may substitute
 - Contact Nestor Zaluzec to discuss your experiment and/or needs
 - Email: Zaluzec@aaem.amc.anl.gov
 - Tel: 630-252-5075 or -7901